Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10051226	LEE ET AL.
Examiner	**Art Unit**
Sheng, Tom V	2629

ORIGINAL	
CLASS	SUBCLASS
345	103

CROSS REFERENCE(S)					
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
345	92				
349	139				

INTERNATIONAL CLASSIFICATION					
CLAIMED					NON-CLAIMED
G	0	9	G	3 / 36 (2006.01.01)	

Sheng, Tom V	4/23/2007	AMR A. AWAD SUPERVISORY PATENT EXAMINER	Total Claims Allowed: 16	
(Assistant Examiner)	(Date)			
(Legal Instruments Examiner)	(Date)	Amr Ahmad Awad 4-27-07 (Primary Examiner) (Date)	O.G. Print Claim(s) 1	O.G. Print Figure 4